

# Publication List

HUANG-MING LEE

## A. 期刊論文

1. **H. M. Lee**, E. Y. Chang, S. H. Chen and C. Y. Chang, “New Nanometer T-Gate Fabricated by Thermally Reflowed Resist Technique”, Jap. J. Appl. Phys., Vol. 41, No. 12B, 2002, pp. L1508-L1510.
2. **H. M. Lee**, T. H. Yang, G. Luo and E. Y. Chang, “Flower-Like Distributed Self-Organized Ge Dots on Patterned Si (001) Substrates”, Jap. J. Appl. Phys., Vol. 42, No. 6B, 2003, pp. L718-L720.
3. H. C. Chang, E. Y. Chang, Y. C. Lien, L. H. Chu, S. W. Chang, R. C. Huang and **H. M. Lee**, “Use of WN<sub>x</sub> as Diffusion Barrier for Copper Airbridged Low Noise GaAs PHEMT”, IEE Electron. Lett., Vol. 39, No. 24, 2003, pp. 1763-1765.
4. **H. M. Lee**, T. H. Yang, G. Luo and E. Y. Chang, “Controlled Placement of Self-Organized Ge Dots on Patterned Si (001) Surfaces”, Jap. J. Appl. Phys., Vol. 43, No. 2B, 2004, pp. L247-L249.
5. Y. C. Lien, E. Y. Chang, H. C. Chang, L. H. Chu, G. W. Huang, **H. M. Lee**, C. S. Lee, S. H. Chen, P. T. Shen and C. Y. Chang, “Low Noise Metamorphic HEMTs with Reflowed 0.1 μm T-Gate”, IEEE Electron. Device Lett., Vol. 25, No. 6, 2004, pp. 348-350.
6. E. Y. Chang, Y. C. Lin, G. J. Chen, **H. M. Lee**, G. W. Huang, D. Biswas and C. Y. Chang, “Composite-Channel Metamorphic High Electron Mobility Transistor for Low-Noise and High-Linearity Applications”, Jap. J. Appl. Phys., Vol. 43, No. 7A, 2004, pp. L871-L872.
7. Y. C. Lin, E. Y. Chang, G. J. Chen, **H. M. Lee**, G. W. Huang, D. Biswas and C. Y. Chang, “InGaP/InGaAs PHEMT with High IP<sub>3</sub> for Low Noise Applications”, IEE Electron. Lett., Vol. 40, No. 12, 2004, pp. 777-778.
8. **H. M. Lee**, K. Muraki, E. Y. Chang and Y. Hirayama, “Electronic Transport Characteristics in a One-Dimensional Constriction Defined by a Triple-Gate Structure”, J. Appl. Phys., Vol. 100, 2006, pp. 043701.

## B. 研討會論文

1. **H. M. Lee**, E. Y. Chang, S. H. Chen and S. C. Huang, 2003, May, “50-nm-T-gate fabricated by thermally reflowed resist technique”, Symposium on Nano Device Technology 2003, pp. 5-8.
2. Y. C. Lien, E. Y. Chang, L. X. Chu, H. C. Chang, C. S. Lee, S. H. Chen; Y. C. Lin and **H. M. Lee**, 2003, September, “A metamorphic high electron-mobility transistor with reflowed submicron T-gate for high-speed optoelectronics applications”, Proceedings of the Sixth Chinese Symposium, pp. 281-283.

3. Y. C. Lien, E. Y. Chang, H. C. Chang, L. H. Chu, K. W. Huang, H. M. Lee, C. S. Lee, S. H. Chen, P. T. Shen, 2003, October, “Low Noise Metamorphic HEMTs with reflowed submicron T-gate”, European Microwave 2003.
4. C. Y. Lu, K. S. Chen, H. M. Lee, E. Y. Chang, S. H. Chen, Y. C. Lin, G. J. Chen, 2003, November, “A low noise composite-channel metamorphic HEMT for wireless communication applications”, The IEEE Electron Devices for Microwave and Optoelectronic Applications, pp. 87-92.
5. Y. C. Lin, E. Y. Chang, G. J. Chen and H. M. Lee, 2003, December, “An InGaP/InGaAs PHEMT with High IP3 for Low Noise Application”, The 12th international workshop on the physics of semiconductor devices, pp. 845-847.
6. H. M. Lee, E. Y. Chang, Y. C. Lin, G. J. Chen, S. H. Chen, C. Y. Chang, 2003, December, “A Composite-channel Metamorphic HEMT with High Channel Breakdown Voltage for Power Applications”, The 12th international workshop on the physics of semiconductor devices, pp. 842-844.
7. L. H. Chu, E. Y. Chang, H. C. Chang, Y. C. Lien, S. W. Chang, R. C. Huang and H. M. Lee, 2004, May, “Copper Airbridged Low Noise GaAs PHEMT with WN<sub>x</sub> as the Diffusion Barrier”, The International Conference on Compound Semiconductor Manufacturing Technology.

### C. 專利

1. 利用熱回流光阻技術製造奈米級閘極於半導體裝置中之方法，張翼，李晃銘(台灣專利 194183，美國專利審查中)。